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Details

Product Status	Obsolete
Core Processor	Coldfire V2
Core Size	32-Bit Single-Core
Speed	80MHz
Connectivity	CANbus, Ethernet, I ² C, QSPI, UART/USART, USB OTG
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	56
Program Memory Size	512KB (512K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	64K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 3.6V
Data Converters	A/D 8x12b
Oscillator Type	Internal
Operating Temperature	0°C ~ 70°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LQFP
Supplier Device Package	100-LQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/pcf52254af80

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1 Family Configurations

Table 1. MCF52259 Family Configurations

Module	52252	52254	52255	52256	52258	52259
Version 2 ColdFire Core with eMAC (Enhanced multiply-accumulate unit) and CAU (Cryptographic acceleration unit)	•	•	•	•	•	•
System Clock	up to 66 or 80 MHz ¹		up to 80 MHz ¹	up to 66 or 80 MHz ¹		up to 80 MHz ¹
Performance (Dhrystone 2.1 MIPS)	up to 63 or 76					
Flash	256 KB	512 KB	512 KB	256 KB	512 KB	512 KB
Static RAM (SRAM)	32 KB	64 KB	64 KB	32 / 64 KB	64 KB	64 KB
Two Interrupt Controllers (INTC)	•	•	•	•	•	•
Fast Analog-to-Digital Converter (ADC)	•	•	•	•	•	•
USB On-The-Go (USB OTG)	•	•	•	•	•	•
Mini-FlexBus external bus interface	—	—	—	•	•	•
Fast Ethernet Controller (FEC)	•	•	•	•	•	•
Random Number Generator and Cryptographic Acceleration Unit (CAU)	—	—	•	—	—	•
FlexCAN 2.0B Module	Varies	Varies	•	Varies	Varies	•
Four-channel Direct-Memory Access (DMA)	•	•	•	•	•	•
Software Watchdog Timer (WDT)	•	•	•	•	•	•
Secondary Watchdog Timer	•	•	•	•	•	•
Two-channel Periodic Interrupt Timer (PIT)	2	2	2	2	2	2
Four-Channel General Purpose Timer (GPT)	•	•	•	•	•	•
32-bit DMA Timers	4	4	4	4	4	4
QSPI	•	•	•	•	•	•
UART(s)	3	3	3	3	3	3
I2C	2	2	2	2	2	2
Eight/Four-channel 8/16-bit PWM Timer	•	•	•	•	•	•
General Purpose I/O Module (GPIO)	•	•	•	•	•	•
Chip Configuration and Reset Controller Module	•	•	•	•	•	•
Background Debug Mode (BDM)	•	•	•	•	•	•
JTAG - IEEE 1149.1 Test Access Port	•	•	•	•	•	•
Package	100 LQFP			144 LQFP or 144 MAPBGA		

¹ 66 MHz = 63 MIPS; 80 MHz = 76 MIPS

1.1 Block Diagram

Figure 1 shows a top-level block diagram of the device. Package options for this family are described later in this document.

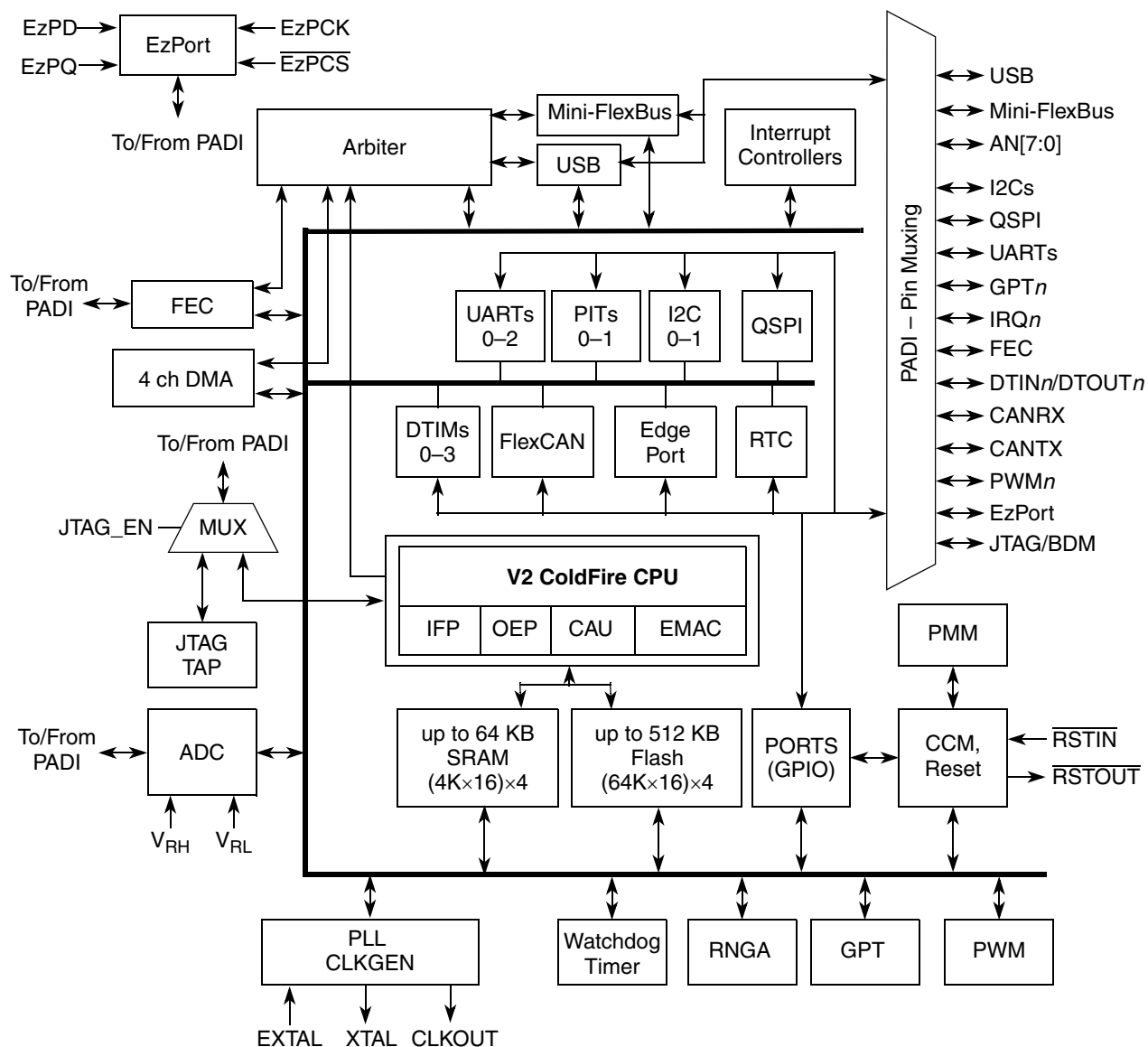


Figure 1. MCF52259 Block Diagram

1.2 Features

1.2.1 Feature Overview

The MCF52259 family includes the following features:

- Version 2 ColdFire variable-length RISC processor core
 - Static operation
 - 32-bit address and data paths on-chip

Family Configurations

- Up to 80 MHz processor core frequency
- 40 MHz or 33 MHz peripheral bus frequency
- Sixteen general-purpose, 32-bit data and address registers
- Implements ColdFire ISA_A with extensions to support the user stack pointer register and four new instructions for improved bit processing (ISA_A+)
- Enhanced Multiply-Accumulate (EMAC) unit with four 32-bit accumulators to support $16 \times 16 \rightarrow 32$ or $32 \times 32 \rightarrow 48$ operations
- Cryptographic Acceleration Unit (CAU)
 - Tightly-coupled coprocessor to accelerate software-based encryption and message digest functions
 - Support for DES, 3DES, AES, MD5, and SHA-1 algorithms
- System debug support
 - Real-time trace for determining dynamic execution path
 - Background debug mode (BDM) for in-circuit debugging (DEBUG_B+)
 - Real-time debug support, with six hardware breakpoints (4 PC, 1 address and 1 data) configurable into a 1- or 2-level trigger
- On-chip memories
 - Up to 64 KB dual-ported SRAM on CPU internal bus, supporting core, DMA, and USB access with standby power supply support for the first 16 KB
 - Up to 512 KB of interleaved flash memory supporting 2-1-1-1 accesses
- Power management
 - Fully static operation with processor sleep and whole chip stop modes
 - Rapid response to interrupts from the low-power sleep mode (wake-up feature)
 - Clock enable/disable for each peripheral when not used (except backup watchdog timer)
 - Software controlled disable of external clock output for low-power consumption
- FlexCAN 2.0B module
 - Based on and includes all existing features of the Freescale TouCAN module
 - Full implementation of the CAN protocol specification version 2.0B
 - Standard data and remote frames (up to 109 bits long)
 - Extended data and remote frames (up to 127 bits long)
 - Zero to eight bytes data length
 - Programmable bit rate up to 1 Mbit/s
 - Flexible message buffers (MBs), totalling up to 16 message buffers of 0–8 byte data length each, configurable as Rx or Tx, all supporting standard and extended messages
 - Unused MB space can be used as general purpose RAM space
 - Listen-only mode capability
 - Content-related addressing
 - No read/write semaphores
 - Three programmable mask registers: global for MBs 0–13, special for MB14, and special for MB15
 - Programmable transmit-first scheme: lowest ID or lowest buffer number
 - Time stamp based on 16-bit free-running timer
 - Global network time, synchronized by a specific message
 - Maskable interrupts
- Universal Serial Bus On-The-Go (USB OTG) dual-mode host and device controller
 - Full-speed / low-speed host controller
 - USB 1.1 and 2.0 compliant full-speed / low speed device controller
 - 16 bidirectional end points

- DMA or FIFO data stream interfaces
- Low power consumption
- OTG protocol logic
- Fast Ethernet controller (FEC)
 - 10/100 BaseT/TX capability, half duplex or full duplex
 - On-chip transmit and receive FIFOs
 - Built-in dedicated DMA controller
 - Memory-based flexible descriptor rings
- Mini-FlexBus
 - External bus interface available on 144 pin packages
 - Supports glueless interface with 8-bit ROM/flash/SRAM/simple slave peripherals. Can address up to 2 MB of addresses
 - 2 chip selects ($\overline{\text{FB_CS}}[1:0]$)
 - Non-multiplexed mode: 8-bit dedicated data bus, 20-bit address bus
 - Multiplexed mode: 16-bit data and 20-bit address bus
 - FB_CLK output to support synchronous memories
 - Programmable base address, size, and wait states to support slow peripherals
 - Operates at up to 40 MHz (bus clock) in 1:2 mode or up to 80 MHz (core clock) in 1:1 mode
- Three universal asynchronous/synchronous receiver transmitters (UARTs)
 - 16-bit divider for clock generation
 - Interrupt control logic with maskable interrupts
 - DMA support
 - Data formats can be 5, 6, 7, or 8 bits with even, odd, or no parity
 - Up to two stop bits in 1/16 increments
 - Error-detection capabilities
 - Modem support includes request-to-send (RTS) and clear-to-send (CTS) lines for two UARTs
 - Transmit and receive FIFO buffers
- Two I2C modules
 - Interchip bus interface for EEPROMs, LCD controllers, A/D converters, and keypads
 - Fully compatible with industry-standard I2C bus
 - Master and slave modes support multiple masters
 - Automatic interrupt generation with programmable level
- Queued serial peripheral interface (QSPI)
 - Full-duplex, three-wire synchronous transfers
 - Up to three chip selects available
 - Master mode operation only
 - Programmable bit rates up to half the CPU clock frequency
 - Up to 16 pre-programmed transfers
- Fast analog-to-digital converter (ADC)
 - Eight analog input channels
 - 12-bit resolution
 - Minimum 1.125 μs conversion time
 - Simultaneous sampling of two channels for motor control applications
 - Single-scan or continuous operation
 - Optional interrupts on conversion complete, zero crossing (sign change), or under/over low/high limit

Family Configurations

- Unused analog channels can be used as digital I/O
- Four 32-bit timers with DMA support
 - 12.5 ns resolution at 80 MHz
 - Programmable sources for clock input, including an external clock option
 - Programmable prescaler
 - Input capture capability with programmable trigger edge on input pin
 - Output compare with programmable mode for the output pin
 - Free run and restart modes
 - Maskable interrupts on input capture or output compare
 - DMA trigger capability on input capture or output compare
- Four-channel general purpose timer
 - 16-bit architecture
 - Programmable prescaler
 - Output pulse-widths variable from microseconds to seconds
 - Single 16-bit input pulse accumulator
 - Toggle-on-overflow feature for pulse-width modulator (PWM) generation
 - One dual-mode pulse accumulation channel
- Pulse-width modulation timer
 - Support for PCM mode (resulting in superior signal quality compared to conventional PWM)
 - Operates as eight channels with 8-bit resolution or four channels with 16-bit resolution
 - Programmable period and duty cycle
 - Programmable enable/disable for each channel
 - Software selectable polarity for each channel
 - Period and duty cycle are double buffered. Change takes effect when the end of the current period is reached (PWM counter reaches zero) or when the channel is disabled.
 - Programmable center or left aligned outputs on individual channels
 - Four clock sources (A, B, SA, and SB) provide for a wide range of frequencies
 - Emergency shutdown
- Two periodic interrupt timers (PITs)
 - 16-bit counter
 - Selectable as free running or count down
- Real-Time Clock (RTC)
 - Maintains system time-of-day clock
 - Provides stopwatch and alarm interrupt functions
 - Standby power supply (Vstby) keeps the RTC running when the system is shut down
- Software watchdog timer
 - 32-bit counter
 - Low-power mode support
- Backup watchdog timer (BWT)
 - Independent timer that can be used to help software recover from runaway code
 - 16-bit counter
 - Low-power mode support
- Clock generation features
 - Crystal, on-chip trimmed relaxation oscillator, or external oscillator reference options
 - Trimmed relaxation oscillator

1.2.2 V2 Core Overview

The version 2 ColdFire processor core is comprised of two separate pipelines decoupled by an instruction buffer. The two-stage instruction fetch pipeline (IFP) is responsible for instruction-address generation and instruction fetch. The instruction buffer is a first-in-first-out (FIFO) buffer that holds prefetched instructions awaiting execution in the operand execution pipeline (OEP). The OEP includes two pipeline stages. The first stage decodes instructions and selects operands (DSOC); the second stage (AGEX) performs instruction execution and calculates operand effective addresses, if needed.

The V2 core implements the ColdFire instruction set architecture revision A+ with support for a separate user stack pointer register and four new instructions to assist in bit processing. Additionally, the core includes the enhanced multiply-accumulate (EMAC) unit for improved signal processing capabilities. The EMAC implements a three-stage arithmetic pipeline, optimized for 32x32 bit operations, with support for four 48-bit accumulators. Supported operands include 16- and 32-bit signed and unsigned integers, signed fractional operands, and a complete set of instructions to process these data types. The EMAC provides support for execution of DSP operations within the context of a single processor at a minimal hardware cost.

1.2.3 Integrated Debug Module

The ColdFire processor core debug interface is provided to support system debugging with low-cost debug and emulator development tools. Through a standard debug interface, access to debug information and real-time tracing capability is provided on 144-lead packages. This allows the processor and system to be debugged at full speed without the need for costly in-circuit emulators.

The on-chip breakpoint resources include a total of nine programmable 32-bit registers: an address and an address mask register, a data and a data mask register, four PC registers, and one PC mask register. These registers can be accessed through the dedicated debug serial communication channel or from the processor's supervisor mode programming model. The breakpoint registers can be configured to generate triggers by combining the address, data, and PC conditions in a variety of single- or dual-level definitions. The trigger event can be programmed to generate a processor halt or initiate a debug interrupt exception. This device implements revision B+ of the ColdFire Debug Architecture.

The processor's interrupt servicing options during emulator mode allow real-time critical interrupt service routines to be serviced while processing a debug interrupt event. This ensures the system continues to operate even during debugging.

To support program trace, the V2 debug module provides processor status (PST[3:0]) and debug data (DDATA[3:0]) ports. These buses and the PSTCLK output provide execution status, captured operand data, and branch target addresses defining processor activity at the CPU's clock rate. The device includes a new debug signal, ALLPST. This signal is the logical AND of the processor status (PST[3:0]) signals and is useful for detecting when the processor is in a halted state (PST[3:0] = 1111).

The full debug/trace interface is available only on the 144-pin packages. However, every product features the dedicated debug serial communication channel (DSI, DSO, DSCLK) and the ALLPST signal.

1.2.4 JTAG

The processor supports circuit board test strategies based on the Test Technology Committee of IEEE and the Joint Test Action Group (JTAG). The test logic includes a test access port (TAP) consisting of a 16-state controller, an instruction register, and three test registers (a 1-bit bypass register, a boundary-scan register, and a 32-bit ID register). The boundary scan register links the device's pins into one shift register. Test logic, implemented using static logic design, is independent of the device system logic.

The device implementation can:

- Perform boundary-scan operations to test circuit board electrical continuity
- Sample system pins during operation and transparently shift out the result in the boundary scan register
- Bypass the device for a given circuit board test by effectively reducing the boundary-scan register to a single bit
- Disable the output drive to pins during circuit-board testing
- Drive output pins to stable levels

Figure 4 shows the pinout configuration for the 144 MAPBGA.

	1	2	3	4	5	6	7	8	9	10	11	12	
A	VSS	RSTOUT	RSTIN	FB_D6	FB_D7	IRQ3	IRQ5	FEC_RXD0	FEC_RXER	FEC_TXEN	FEC_TXD3	VSS	A
B	TEST	FB_A14	FB_D4	FB_D5	FB_OE	FB_A19	FEC_RXD1	FEC_RXCLK	FEC_TXCLK	FEC_TXD2	FEC_COL	FEC_CRS	B
C	TIN1	FB_A12	FB_A13	FB_A15	FB_A16	FB_A18	FEC_RXD2	FEC_RXDV	FEC_TXD1	URXD2	VDDPLL	EXTAL	C
D	RTC_EXTAL	TIN0	FB_A11	CLKMOD1	CLKMOD0	FB_A17	FEC_RXD3	FEC_TXER	FEC_TXD0	UTXD2	VSSPLL	XTAL	D
E	RTC_XTAL	UCTS0	FB_A10	RCON	VDD	VDD	VDD	VDD	IRQ1	URTS2	UCTS2	IRQ7	E
F	UTXD0	URXD0	URTS0	TIN3	VDD	VSS	VSS	VSS	PST3	DDATA0	DDATA1	ICOC0	F
G	QSDO	QSDI	PCS2	PCS3	VDD	VSS	VSS	VSS	DDATA3	PST2	PST1	PST0	G
H	SCL	SDA	SCK	PCS0	VDD	VDD	VDD	VSS	VSSUSB	DDATA2	USB_DM	USB_DP	H
J	FB_A6	FB_A7	FB_A9	FB_A8	FB_D0	FB_A3	VDD	TIN2	VDDUSB	ICOC2	ICOC1	VSTBY	J
K	TMS	TRST	FB_ALE	FB_A5	FB_D2	FB_A4	UCTS1	UTXD1	AN3	AN6	AN4	AN5	K
L	TDI	TDO	ALLPST	FB_D3	FB_D1	FB_A1	FB_A0	URXD1	AN2	VRH	VDDA	AN7	L
M	VSS	JTAG_EN	TCLK	FB_RW	FB_CS0	FB_A2	ICOC3	URTS1	AN0	AN1	VRL	VSSA	M
	1	2	3	4	5	6	7	8	9	10	11	12	

Figure 4. Pinout Top View (144 MAPBGA)

Table 3 shows the pin functions by primary and alternate purpose, and illustrates which packages contain each pin.

Table 3. Pin Functions by Primary and Alternate Purpose

Pin Group	Primary Function	Secondary Function (Alt 1)	Tertiary Function (Alt 2)	Quaternary Function (GPIO)	Slew Rate	Drive Strength/Control ¹	Pull-up/Pull-down ²	Pin on 144 MAPBGA	Pin on 144 LQFP	Pin on 100 LQFP
ADC	AN[7:0]	—	—	PAN[7:0]	Low	Low	—	L12, K10, K12, K11, K9, L9, M10, M9	74–77; 69, 68, 67, 66	51–54, 46, 45, 44, 43
	VDDA	—	—	—	N/A	N/A	—	L11	73	50
	VSSA	—	—	—	N/A	N/A	—	M12	70	47
	VRH	—	—	—	N/A	N/A	—	L10	72	49
	VRL	—	—	—	N/A	N/A	—	M11	71	48
Clock Generation	EXTAL	—	—	—	N/A	N/A	—	C12	106	73
	XTAL	—	—	—	N/A	N/A	—	D12	105	72
	VDDPLL	—	—	—	N/A	N/A	—	C11	107	74
	VSSPLL	—	—	—	N/A	N/A	—	D11	104	71
RTC	RTC_EXTAL	—	—	—	N/A	N/A	—	D1	13	7
	RTC_XTAL	—	—	—	N/A	N/A	—	E1	14	8
Debug Data	ALLPST	—	—	—	Low	High	—	L3	42	30
	DDATA[3:0]	—	—	PDD[7:4]	Low	High	—	G9, H10, F11, F10	86, 85, 84, 83	—
	PST[3:0]	—	—	PDD[3:0]	Low	High	—	F9, G10, G11, G12	87–90	—

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

Pin Group	Primary Function	Secondary Function (Alt 1)	Tertiary Function (Alt 2)	Quaternary Function (GPIO)	Slew Rate	Drive Strength/Control ¹	Pull-up/Pull-down ²	Pin on 144 MAPBGA	Pin on 144 LQFP	Pin on 100 LQFP
Mode Selection	RCON/EZPCS	—	—	—	N/A	N/A	Pull-Up	E4	10	4
	CLKMOD[1:0]	—	—	—	N/A	N/A	Pull-Down	D4, D5	144, 143	100, 99
QSPI	QSPI_CS3	SYNCA	USB_DP_PDOWN	PQS6	PSRR[7]	PDSR[7]	—	G4	22	16
	QSPI_CS2	SYNCB	USB_DM_PDOWN	PQS5	PSRR[6]	PDSR[6]	—	G3	23	17
	QSPI_CS0	I2C_SDA0	UCTS1	PQS3	PSRR[4]	PDSR[4]	Pull-Up ⁶	H4	27	21
	QSPI_CLK/EZPCK	I2C_SCL0	URTS1	PQS2	PSRR[3]	PDSR[3]	Pull-Up ⁶	H3	26	20
QSPI	QSPI_DIN/EZPD	I2C_SDA1	URXD1	PQS1	PSRR[2]	PDSR[2]	Pull-Up ⁶	G2	24	18
	QSPI_DOUT/EZPQ	I2C_SCL1	UTXD1	PQS0	PSRR[1]	PDSR[1]	Pull-Up ⁶	G1	25	19
Reset ⁷	RSTI	—	—	—	N/A	N/A	Pull-Up ⁷	A3	141	97
	RSTO	—	—	—	Low	High	—	A2	142	98
Test	TEST	—	—	—	N/A	N/A	Pull-Down	B1	9	3
Timer 3, 16-bit	GPT3	—	PWM7	PTA3	PSRR[23]	PDSR[23]	Pull-Up ⁸	M7	58	35
Timer 2, 16-bit	GPT2	—	PWM5	PTA2	PSRR[22]	PDSR[22]	Pull-Up ⁸	J10	95	62
Timer 1, 16-bit	GPT1	—	PWM3	PTA1	PSRR[21]	PDSR[21]	Pull-Up ⁸	J11	94	61
Timer 0, 16-bit	GPT0	—	PWM1	PTA0	PSRR[20]	PDSR[20]	Pull-Up ⁸	F12	93	60
Timer 3, 32-bit	DTIN3	DTOUT3	PWM6	PTC3	PSRR[19]	PDSR[19]	—	F4	19	13
Timer 2, 32-bit	DTIN2	DTOUT2	PWM4	PTC2	PSRR[18]	PDSR[18]	—	J8	65	42

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

Pin Group	Primary Function	Secondary Function (Alt 1)	Tertiary Function (Alt 2)	Quaternary Function (GPIO)	Slew Rate	Drive Strength/Control ¹	Pull-up/ Pull-down ²	Pin on 144 MAPBGA	Pin on 144 LQFP	Pin on 100 LQFP
Mini-FlexBus ⁹	FB_ALE	FB_CS1	—	PAS2	PSRRL[20]	PDSRL[20]	—	K3	37	—
	FB_AD[7:0]	—	—	PTE[7:0]	PSRRL[7:0]	PDSRL[7:0]	—	J2, J1, K4, K6, J6, M6, L6, L7	34–36; 53–57	—
	FB_AD[15:8]	—	—	PTF[7:0]	PSRRL[15:8]	PDSRL[15:8]	—	C4, B2, C3, C2, D3, E3, J3, J4	136, 2–6, 32–33	—
	FB_AD[19:16]	—	—	PTG[3:0]	PSRRL[19:16]	PDSRL[19:16]	—	B6, C6, D6, C5	130–133	—
	FB_CS0	—	—	PTG5	PSRRL[21]	PDSRL[21]	—	M5	52	—
	FB_R/ \overline{W}	—	—	PTG7	PSRRL[31]	PDSRL[31]	—	M4	45	—
	FB_OE	—	—	PTG6	PSRRL[30]	PDSRL[30]	—	B5	137	—
	FB_D7	CANRX	—	PTH5	PSRRL[29]	PDSRL[29]	—	A5	138	—
	FB_D6	CANTX	—	PTH4	PSRRL[28]	PDSRL[28]	—	A4	139	—
	FB_D5	I2C_SCL1	—	PTH3	PSRRL[27]	PDSRL[27]	Pull-Up ⁶	B4	140	—
	FB_D4	I2C_SDA1	—	PTH2	PSRRL[26]	PDSRL[26]	Pull-Up ⁶	B3	1	—
	FB_D3	USB_VBUS _D	—	PTH1	PSRRL[25]	PDSRL[25]	—	L4	46	—
	FB_D2	USB_VBU _{SE}	—	PTH0	PSRRL[24]	PDSRL[24]	—	K5	47	—
	FB_D1	SYNCA	—	PTH7	PSRRL[23]	PDSRL[23]	—	L5	50	—
	FB_D0	SYNCB	—	PTH6	PSRRL[22]	PDSRL[22]	—	J5	51	—
Standby Voltage	VSTBY	—	—	—	N/A	N/A	—	J12	78	55
VDD ¹⁰	VDD	—	—	—	N/A	N/A	—	E5–E8; F5; G5; H5–7; J7	7; 20; 30; 48; 59; 92; 100; 115; 125; 135	1; 14; 24; 33; 36; 67; 82; 92

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

Pin Group	Primary Function	Secondary Function (Alt 1)	Tertiary Function (Alt 2)	Quaternary Function (GPIO)	Slew Rate	Drive Strength/Control ¹	Pull-up/Pull-down ²	Pin on 144 MAPBGA	Pin on 144 LQFP	Pin on 100 LQFP
VSS	VSS	—	—	—	N/A	N/A	—	A1; A12; F6–8; G6–8; H8; M1	8; 21; 31; 49; 60; 91; 99; 114; 124; 134	2; 15; 25; 34; 37; 66; 81; 91

¹ The PDSR and PSSR registers are part of the GPIO module. All programmable signals default to 2mA drive in normal (single-chip) mode.

² All signals have a pull-up in GPIO mode.

³ I2C1 is multiplexed with specific pins of the QSPI, UART1, UART2, and Mini-FlexBus pin groups.

⁴ For primary and GPIO functions only.

⁵ Only when JTAG mode is enabled.

⁶ For secondary and GPIO functions only.

⁷ RSTI has an internal pull-up resistor; however, the use of an external resistor is strongly recommended.

⁸ For GPIO functions, the Primary Function has pull-up control within the GPT module.

⁹ Available on 144-pin packages only.

¹⁰ This list for power and ground does not include those dedicated power/ground pins included elsewhere, such as in the ADC, USB, and PLL.

Table 7. Current Consumption in Low-Power Mode, Code From SRAM^{1,2,3}

Mode	8 MHz (Typ)	16 MHz (Typ)	64 MHz (Typ)	80 MHz (Typ)	Unit	Symbol
Stop mode 3 (Stop 11) ⁴	0.090				mA	I _{DD}
Stop mode 2 (Stop 10) ⁴	7					
Stop mode 1 (Stop 01) ^{4,5}	9	10	15	17		
Stop mode 0 (Stop 00) ⁵	9	10	15	17		
Wait / Doze	13	18	42	50		
Run	16	21	55	65		

¹ All values are measured with a 3.3 V power supply. Tests performed at room temperature.

² Refer to the Power Management chapter in the *MCF52259 Reference Manual* for more information on low-power modes.

³ CLKOUT, PST/DDATA signals, and all peripheral clocks except UART0 off before entering low-power mode. CLKOUT is disabled. Code executed from SRAM with flash memory shut off by writing 0x0 to the FLASHBAR register.

⁴ See the description of the Low-Power Control Register (LPCR) in the *MCF52259 Reference Manual* for more information on stop modes 0–3.

⁵ Results are identical to STOP 00 for typical values because they only differ by CLKOUT power consumption. CLKOUT is already disabled in this instance prior to entering low-power mode.

2.3 Thermal Characteristics

Table 8 lists thermal resistance values.

Table 8. Thermal Characteristics

	Characteristic		Symbol	Value	Unit
144 MAPBGA	Junction to ambient, natural convection	Single layer board (1s)	θ_{JA}	53 ^{1,2}	°C/W
	Junction to ambient, natural convection	Four layer board (2s2p)	θ_{JA}	30 ^{1,3}	°C/W
	Junction to ambient, (@200 ft/min)	Single layer board (1s)	θ_{JMA}	43 ^{1,3}	°C/W
	Junction to ambient, (@200 ft/min)	Four layer board (2s2p)	θ_{JMA}	26 ^{1,3}	°C/W
	Junction to board	—	θ_{JB}	16 ⁴	°C/W
	Junction to case	—	θ_{JC}	9 ⁵	°C/W
	Junction to top of package	Natural convection	Ψ_{jt}	2 ⁶	°C/W
	Maximum operating junction temperature	—	T_j	105	°C
144 LQFP	Junction to ambient, natural convection	Single layer board (1s)	θ_{JA}	44 ^{7,8}	°C/W
	Junction to ambient, natural convection	Four layer board (2s2p)	θ_{JA}	35 ^{1,9}	°C/W
	Junction to ambient, (@200 ft/min)	Single layer board (1s)	θ_{JMA}	35 ^{1,3}	°C/W
	Junction to ambient, (@200 ft/min)	Four layer board (2s2p)	θ_{JMA}	29 ^{1,3}	°C/W
	Junction to board	—	θ_{JB}	23 ¹⁰	°C/W
	Junction to case	—	θ_{JC}	7 ¹¹	°C/W
	Junction to top of package	Natural convection	Ψ_{jt}	2 ¹²	°C/W
	Maximum operating junction temperature	—	T_j	105	°C

Table 8. Thermal Characteristics (continued)

	Characteristic		Symbol	Value	Unit
100 LQFP	Junction to ambient, natural convection	Single layer board (1s)	θ_{JA}	53 ^{13,14}	°C/W
	Junction to ambient, natural convection	Four layer board (2s2p)	θ_{JA}	39 ^{1,15}	°C/W
	Junction to ambient, (@200 ft/min)	Single layer board (1s)	θ_{JMA}	42 ^{1,3}	°C/W
	Junction to ambient, (@200 ft/min)	Four layer board (2s2p)	θ_{JMA}	33 ^{1,3}	°C/W
	Junction to board	—	θ_{JB}	25 ¹⁶	°C/W
	Junction to case	—	θ_{JC}	9 ¹⁷	°C/W
	Junction to top of package	Natural convection	Ψ_{jt}	2 ¹⁸	°C/W
	Maximum operating junction temperature	—	T_j	105	°C

¹ θ_{JA} and Ψ_{jt} parameters are simulated in conformance with EIA/JESD Standard 51-2 for natural convection. Freescale recommends the use of θ_{JA} and power dissipation specifications in the system design to prevent device junction temperatures from exceeding the rated specification. System designers should be aware that device junction temperatures can be significantly influenced by board layout and surrounding devices. Conformance to the device junction temperature specification can be verified by physical measurement in the customer's system using the Ψ_{jt} parameter, the device power dissipation, and the method described in EIA/JESD Standard 51-2.

² Per JEDEC JESD51-2 with the single-layer board (JESD51-3) horizontal.

³ Per JEDEC JESD51-6 with the board JESD51-7) horizontal.

⁴ Thermal resistance between the die and the printed circuit board in conformance with JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.

⁵ Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).

⁶ Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written in conformance with Psi-JT.

⁷ θ_{JA} and Ψ_{jt} parameters are simulated in conformance with EIA/JESD Standard 51-2 for natural convection. Freescale recommends the use of θ_{JA} and power dissipation specifications in the system design to prevent device junction temperatures from exceeding the rated specification. System designers should be aware that device junction temperatures can be significantly influenced by board layout and surrounding devices. Conformance to the device junction temperature specification can be verified by physical measurement in the customer's system using the Ψ_{jt} parameter, the device power dissipation, and the method described in EIA/JESD Standard 51-2.

⁸ Per JEDEC JESD51-2 with the single-layer board (JESD51-3) horizontal.

⁹ Per JEDEC JESD51-6 with the board JESD51-7) horizontal.

¹⁰ Thermal resistance between the die and the printed circuit board in conformance with JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.

¹¹ Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).

¹² Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written in conformance with Psi-JT.

¹³ θ_{JA} and Ψ_{jt} parameters are simulated in conformance with EIA/JESD Standard 51-2 for natural convection. Freescale recommends the use of θ_{JA} and power dissipation specifications in the system design to prevent device junction temperatures from exceeding the rated specification. System designers should be aware that device junction temperatures can be significantly influenced by board layout and surrounding devices. Conformance to the device junction temperature specification can be verified by physical measurement in the customer's system using the Ψ_{jt} parameter, the device power dissipation, and the method described in EIA/JESD Standard 51-2.

¹⁴ Per JEDEC JESD51-2 with the single-layer board (JESD51-3) horizontal.

¹⁵ Per JEDEC JESD51-6 with the board JESD51-7) horizontal.

2.9 USB Operation

Table 15. USB Operation Specifications

Characteristic	Symbol	Value	Unit
Minimum core speed for USB operation	$f_{\text{sys_USB_min}}$	16	MHz

2.10 Mini-FlexBus External Interface Specifications

A multi-function external bus interface called Mini-FlexBus is provided with basic functionality to interface to slave-only devices up to a maximum bus frequency of 80 MHz. It can be directly connected to asynchronous or synchronous devices such as external boot ROMs, flash memories, gate-array logic, or other simple target (slave) devices with little or no additional circuitry. For asynchronous devices a simple chip-select based interface can be used.

All processor bus timings are synchronous; that is, input setup/hold and output delay are given in respect to the rising edge of a reference clock, MB_CLK. The MB_CLK frequency is half the internal system bus frequency.

The following timing numbers indicate when data is latched or driven onto the external bus, relative to the Mini-FlexBus output clock (MB_CLK). All other timing relationships can be derived from these values.

Table 16. Mini-FlexBus AC Timing Specifications

Num	Characteristic	Min	Max	Unit	Notes
	Frequency of Operation	—	80	MHz	
MB1	Clock Period	12.5	—	ns	
MB2	Output Valid	—	8	ns	¹
MB3	Output Hold	2	—	ns	¹
MB4	Input Setup	6	—	ns	²
MB5	Input Hold	0	—	ns	²

¹ Specification is valid for all MB_A[19:0], MB_D[7:0], MB_CS[1:0], MB_OE, MB_R/W, and MB_ALE.

² Specification is valid for all MB_D[7:0].

2.11.1 Receive Signal Timing Specifications

The following timing specs meet the requirements for MII and 7-Wire style interfaces for a range of transceiver devices.

Table 17. Receive Signal Timing

Num	Characteristic	MII Mode		Unit
		Min	Max	
—	RXCLK frequency	—	25	MHz
E1	RXD[n:0], RXDV, RXER to RXCLK setup ¹	5	—	ns
E2	RXCLK to RXD[n:0], RXDV, RXER hold ¹	5	—	ns
E3	RXCLK pulse width high	35%	65%	RXCLK period
E4	RXCLK pulse width low	35%	65%	RXCLK period

¹ In MII mode, n = 3

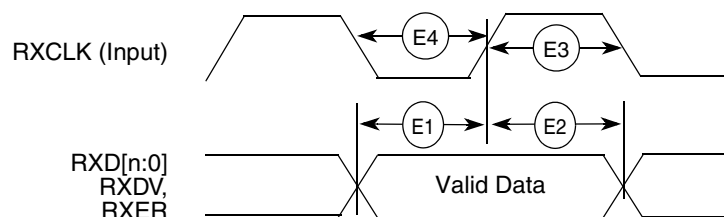


Figure 7. MII Receive Signal Timing Diagram

2.11.2 Transmit Signal Timing Specifications

Table 18. Transmit Signal Timing

Num	Characteristic	MII Mode		Unit
		Min	Max	
—	TXCLK frequency	—	25	MHz
E5	TXCLK to TXD[n:0], TXEN, TXER invalid ¹	5	—	ns
E6	TXCLK to TXD[n:0], TXEN, TXER valid ¹	—	25	ns
E7	TXCLK pulse width high	35%	65%	t _{TXCLK}
E8	TXCLK pulse width low	35%	65%	t _{TXCLK}

¹ In MII mode, n = 3

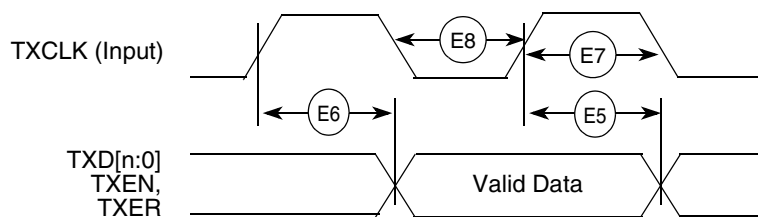


Figure 8. MII Transmit Signal Timing Diagram

Table 25. ADC Parameters¹ (continued)

Name	Characteristic	Min	Typical	Max	Unit
SNR	Signal-to-noise ratio	—	62 to 66	—	dB
THD	Total harmonic distortion	—	–75	—	dB
SFDR	Spurious free dynamic range	—	67 to 70.3	—	dB
SINAD	Signal-to-noise plus distortion	—	61 to 63.9	—	dB
ENOB	Effective number of bits	9.1	10.6	—	Bits

¹ All measurements are preliminary pending full characterization, and made at $V_{DD} = 3.3\text{ V}$, $V_{REFH} = 3.3\text{ V}$, and $V_{REFL} = \text{ground}$

² INL measured from $V_{IN} = V_{REFL}$ to $V_{IN} = V_{REFH}$

³ LSB = Least Significant Bit

⁴ INL measured from $V_{IN} = 0.1V_{REFH}$ to $V_{IN} = 0.9V_{REFH}$

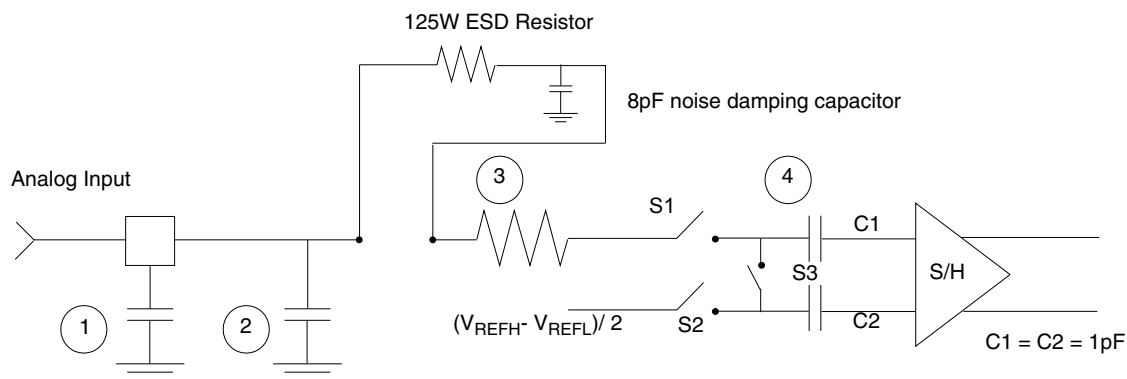
⁵ Includes power-up of ADC and V_{REF}

⁶ ADC clock cycles

⁷ Current that can be injected or sourced from an unselected ADC signal input without impacting the performance of the ADC

2.16 Equivalent Circuit for ADC Inputs

Figure 14 shows the ADC input circuit during sample and hold. S1 and S2 are always open/closed at the same time that S3 is closed/open. When S1/S2 are closed and S3 is open, one input of the sample and hold circuit moves to $(V_{REFH} - V_{REFL})/2$, while the other charges to the analog input voltage. When the switches are flipped, the charge on C1 and C2 are averaged via S3, with the result that a single-ended analog input is switched to a differential voltage centered about $(V_{REFH} - V_{REFL})/2$. The switches switch on every cycle of the ADC clock (open one-half ADC clock, closed one-half ADC clock). There are additional capacitances associated with the analog input pad, routing, etc., but these do not filter into the S/H output voltage, as S1 provides isolation during the charge-sharing phase. One aspect of this circuit is that there is an on-going input current, which is a function of the analog input voltage, V_{REF} and the ADC clock frequency.



1. Parasitic capacitance due to package, pin-to-pin and pin-to-package base coupling; 1.8 pF
2. Parasitic capacitance due to the chip bond pad, ESD protection devices and signal routing; 2.04 pF
3. Equivalent resistance for the channel select mux; 100 Ω
4. Sampling capacitor at the sample and hold circuit. Capacitor C1 is normally disconnected from the input and is only connected to it at sampling time; 1.4 pF
5. Equivalent input impedance, when the input is selected =
$$\frac{1}{(\text{ADC Clock Rate}) \times (1.4 \times 10^{-12})}$$

Figure 14. Equivalent Circuit for A/D Loading

2.17 DMA Timers Timing Specifications

Table 26 lists timer module AC timings.

Table 26. Timer Module AC Timing Specifications

Name	Characteristic ¹	Min	Max	Unit
T1	DTIN0 / DTIN1 / DTIN2 / DTIN3 cycle time	$3 \times t_{CYC}$	—	ns
T2	DTIN0 / DTIN1 / DTIN2 / DTIN3 pulse width	$1 \times t_{CYC}$	—	ns

¹ All timing references to CLKOUT are given to its rising edge.

2.18 QSPI Electrical Specifications

Table 27 lists QSPI timings.

Table 27. QSPI Modules AC Timing Specifications

Name	Characteristic	Min	Max	Unit
QS1	QSPI_CS[3:0] to QSPI_CLK	1	510	t_{CYC}
QS2	QSPI_CLK high to QSPI_DOUT valid	—	10	ns
QS3	QSPI_CLK high to QSPI_DOUT invalid (Output hold)	2	—	ns
QS4	QSPI_DIN to QSPI_CLK (Input setup)	9	—	ns
QS5	QSPI_DIN to QSPI_CLK (Input hold)	9	—	ns

The values in Table 27 correspond to Figure 15.

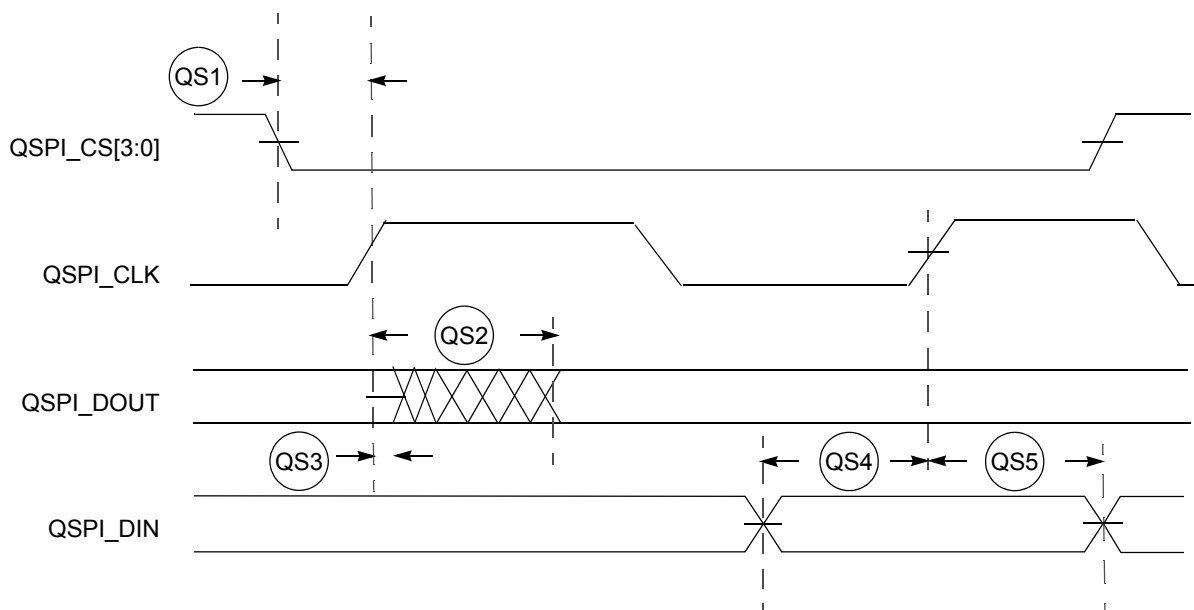


Figure 15. QSPI Timing

2.19 JTAG and Boundary Scan Timing

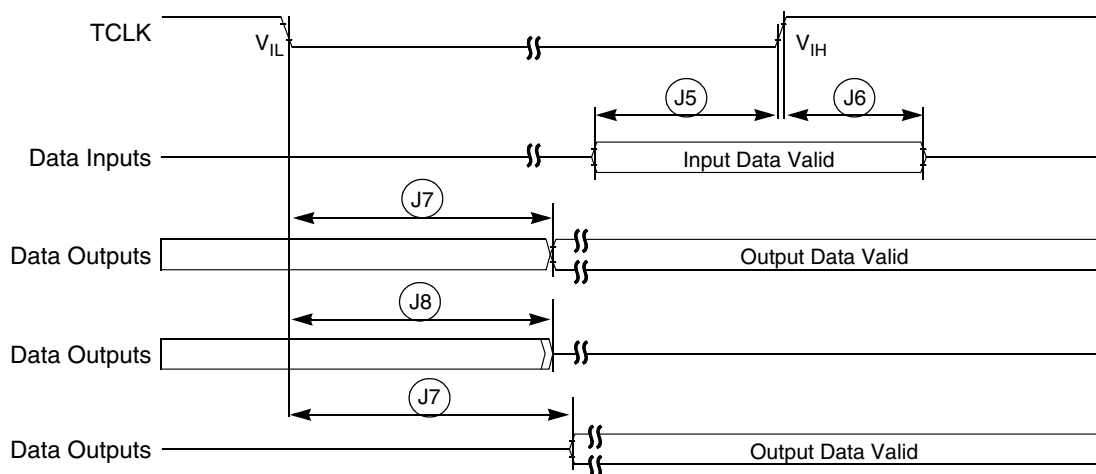


Figure 17. Boundary Scan (JTAG) Timing

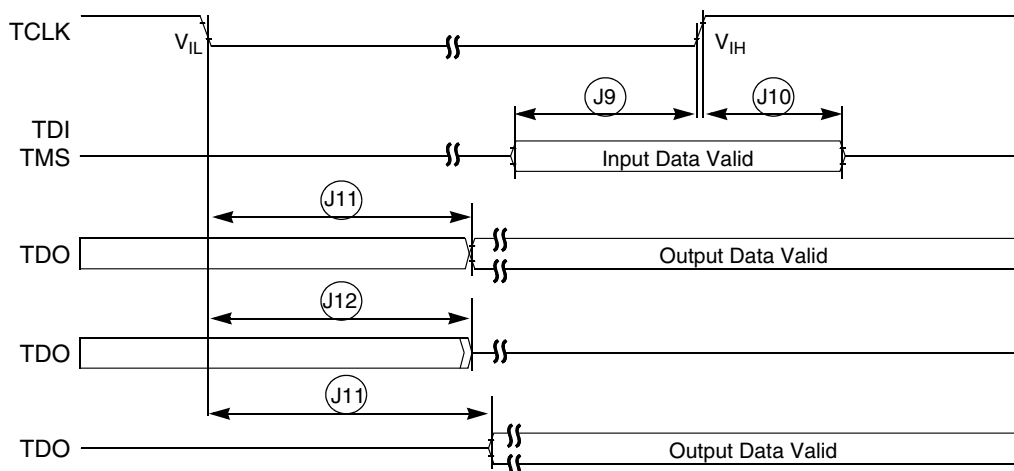
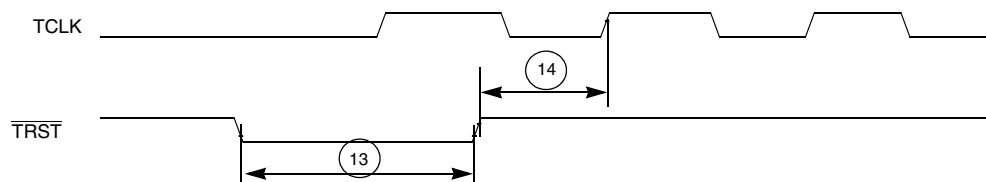


Figure 18. Test Access Port Timing

Figure 19. $\overline{\text{TRST}}$ Timing

2.20 Debug AC Timing Specifications

Table 29 lists specifications for the debug AC timing parameters shown in Figure 21.

Table 29. Debug AC Timing Specification

Num	Characteristic	66/80 MHz		Units
		Min	Max	
D1	PST, DDATA to CLKOUT setup	4	—	ns
D2	CLKOUT to PST, DDATA hold	1.5	—	ns
D3	DSI-to-DSCLK setup	$1 \times t_{CYC}$	—	ns
D4 ¹	DSCLK-to-DSO hold	$4 \times t_{CYC}$	—	ns
D5	DSCLK cycle time	$5 \times t_{CYC}$	—	ns
D6	\overline{BKPT} input data setup time to CLKOUT rise	4	—	ns
D7	\overline{BKPT} input data hold time to CLKOUT rise	1.5	—	ns
D8	CLKOUT high to \overline{BKPT} high Z	0.0	10.0	ns

¹ DSCLK and DSI are synchronized internally. D4 is measured from the synchronized DSCLK input relative to the rising edge of CLKOUT.

Figure 20 shows real-time trace timing for the values in Table 29.

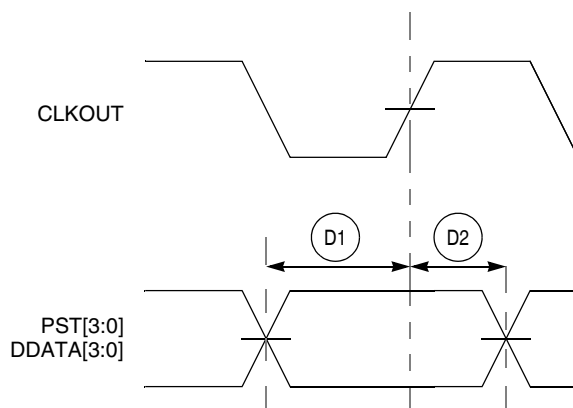


Figure 20. Real-Time Trace AC Timing